

**Search Notes**

Application/Control No.

10/749,178

Examiner

Mark A. Chapman

Applicant(s)/Patent under  
Reexamination

TOKARSKI ET AL.

Art Unit

1756

**SEARCHED**

Class	Subclass	Date	Examiner
430	75	9/25/2005	MC
	77		
	79		
	58.05		
	126		
399	159		
549	1		
	90		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
430	75,77	9/25/2005	MC
	79,58.05		
	126		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	9/25/2005	MC
STIC search		
reviewed related applications		